## Application/Control No. Applicant(s)/Patent Under Reexamination TANAKA ET AL. Examiner Jeffrey R. West Applicant(s)/Patent Under Reexamination TANAKA ET AL. Page 1 of 1

## U.S. PATENT DOCUMENTS

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	М	US-			

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## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
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